

<b>Notice of References Cited</b>	Application/Control No. 10/673,145		Applicant(s)/Patent Under Reexamination SA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,320,629	11-2001	Hatano et al.	349/15
*	B	US-6,384,878	05-2002	Kwak, Sang-Ki	349/40
*	C	US-6,359,672	03-2002	Gu et al.	349/138
*	D	US-6,582,862	06-2003	Nakamura et al.	430/7
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	T	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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